

Search Notes

Application/Control No.

10/566,583

Examiner

Lindsay M. Low

Applicant(s)/Patent under
Reexamination

KAMEDA, FUTOSHI

Art Unit

3721

SEARCHED

Class	Subclass	Date	Examiner
227	107, 119, 120, 135, 139	7/23/2007	LL

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR